

Notice of References Cited	Application/Control No. 10/776,286	Applicant(s)/Patent Under Reexamination ONOZAWA ET AL.	
	Examiner Leith A. Al-Nazer	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,426,594	07-2002	Ito, Akihiko	315/169.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO 02/095914 A2	11-2002	World	Stanley, Gerald R.	H02M
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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